

Notice of References Cited	Application/Control No. 10/576,162		Applicant(s)/Patent Under Reexamination OOMEN ET AL.	
	Examiner DAVID E. HARVEY		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2006/0153524	07-2006	Damstra et al.	386/083
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	N	EP 794,667	10-1997	Europe	Faninami et al	-----
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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